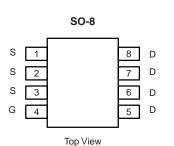
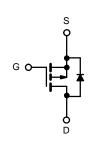


P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
	$0.015 \text{ at V}_{GS} = -4.5 \text{ V}$	- 13 ^a			
- 20	0.021 at V _{GS} = - 2.5 V	- 10 ^a	20 nC		
	0.040 at V _{GS} = - 1.8 V	- 8			





P-Channel MOSFET

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested Built in ESD Protection with Zener Diode
- Typical ESD Performance: 1800 V
- Compliant to RoHS Directive 2002/95/EC

HALOGEN

FREE

APPLICATIONS

- Portable Devices
 - Load Switch
 - Battery Switch
 - Charger Switch

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	- 20		
Gate-Source Voltage	V_{GS}	± 12	V	
	T _C = 25 °C		- 13 ^a	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I-	- 10 ^a	
Continuous Diam Current (1) = 130 C)	T _A = 25 °C	I _D	- 8 ^{b, c}	
	T _A = 70 °C		- 7.1 ^{b, c}	Α
Pulsed Drain Current		I _{DM} - 50	- 50	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 6 ^a	
Continuous Course Brain Blode Guirent	$T_A = 25 ^{\circ}C$	'S	- 2.9 ^{b, c}	
	T _C = 25 °C		19	
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	12	W
	$T_A = 25 ^{\circ}C$	' D	3.5 ^{b, c}	
	T _A = 70 °C		2.2 ^{b, c}	7
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperatur		260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, e}	t ≤ 5 s	R _{thJA}	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	5.3	6.5] 5/**	

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under Steady State conditions is 80 °C/W.



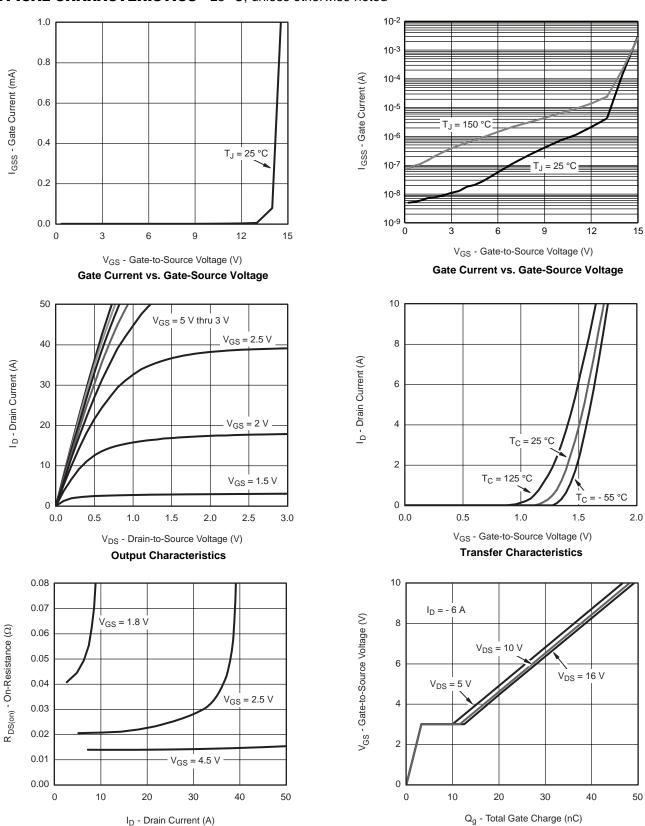
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•	l		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 12		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 250 μA		3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.5		- 1.2	V	
Gate-Source Leakage	1	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 20	μА	
	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 0.5		
Zoro Coto Voltogo Droin Current		V _{DS} = - 20 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 55 °C			- 10	1	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
		V _{GS} = - 4.5 V, I _D = - 5.6 A		0.015		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -5.3 \text{ A}$		0.021			
		$V_{GS} = -1.8 \text{ V}, I_D = -2.5 \text{ A}$		0.040			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 5.6 A		35		S	
Dynamic ^b					L	L	
Total Gate Charge		V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 5 A		50	75	nC	
Gate-Source Charge	Q_g	50 50		20	30		
	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		3.3			
Gate-Drain Charge	Q _{gd}			8.4			
Gate Resistance	R_{g}	f = 1 MHz	0.2	1	2	kΩ	
Turn-On Delay Time	t _{d(on)}			0.71	1.1		
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		1.7	2.6		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1$		6	9	1	
Fall Time	t _f	Ω		3.2	5		
Turn-On Delay Time	t _{d(on)}			0.3	0.45	us	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 1 Ω		0.6	0.9		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 5 A, V_{GEN} = - 10 V, R_g = 1		10	15		
Fall Time	t _f	Ω		3.5	5.5		
Drain-Source Body Diode Characterist	ics			•			
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			- 6	A	
Pulse Diode Forward Current	I _{SM}				- 50	1 ^	
Body Diode Voltage	V_{SD}	I _S = - 5 A, V _{GS} = 0 V		- 0.85	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			30	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 6.4 dl/dt = 100 A/us T = 25.00		20	40	nC	
Reverse Recovery Fall Time	t _a	$I_F = 6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		13			
Reverse Recovery Rise Time	t _b			17		ns	

Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$ b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



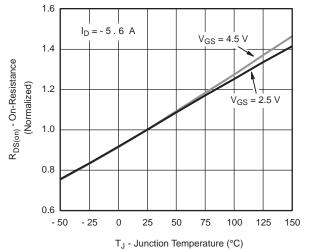


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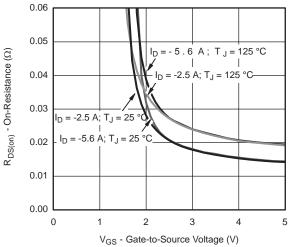
On-Resistance vs. Drain Current

Gate Charge

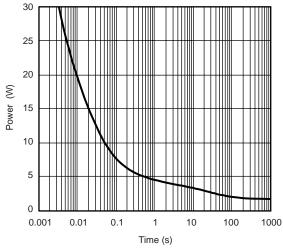




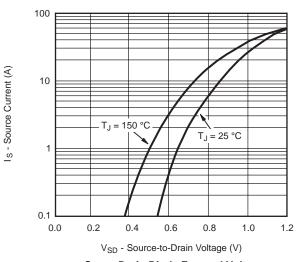
On-Resistance vs. Junction Temperature



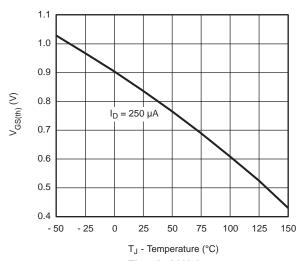
On-Resistance vs. Gate-to-Source Voltage



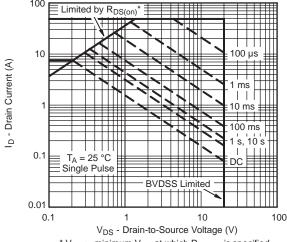
Single Pulse Power, Junction-to-Ambient



Soure-Drain Diode Forward Voltage



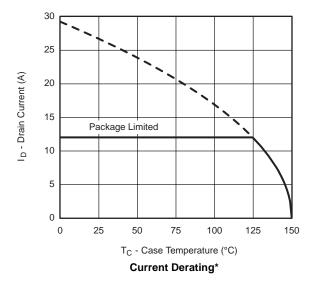
Threshold Voltage

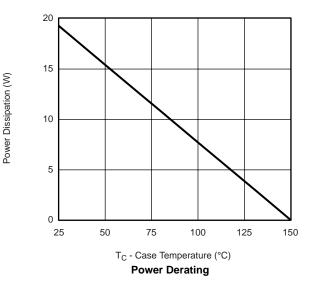


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

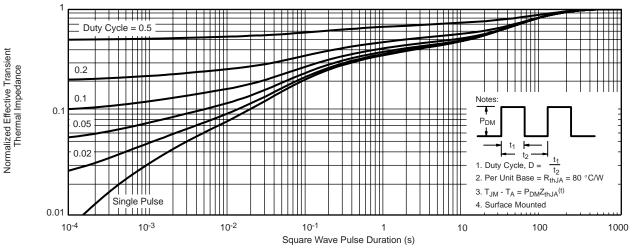




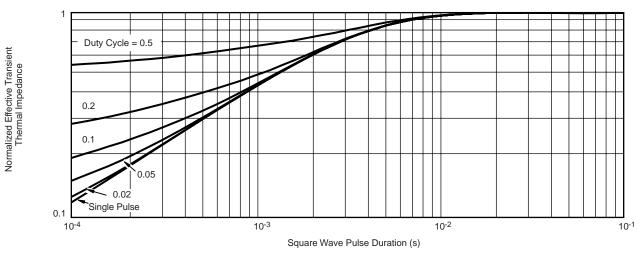


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





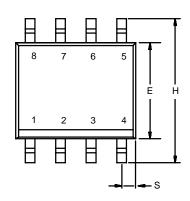
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







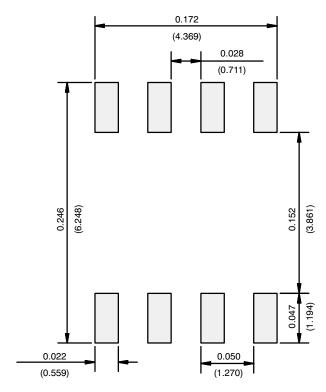
	MILLIM	MILLIMETERS INCHES				
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Pey 11-Sep-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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